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FORM F <sup>F</sup> TO 1449 (			ATTY DOCKET NO. 03500.015727.	APPLICATION	NO. <b>09/941,78</b>	0
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	6,472,814 B1	10/02	Yamanobe et al.	313	495	11/23/98
	5,847,495	12/98	Yamanobe et al.	313	310	
	5,066,883	11/91	Yoshioka et al.	313	309	
	6,455,021 B1	09/02	Saito	423	447.3	07/20/99
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·	6,283,812 B1	09/01	Jin et al.	445	24	01/25/99
	4,816,289	03/89	Komatsu et al	423	447.3	
	5,443,859	08/95	Nagata	427	122	
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	5,965,267	10/99	Nolan et al.	428	408	·
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<sup>\*</sup>EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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	6,390,612 B1	05/02	Kota	ki et al.	347	85	
	5,872,541	02/99	Yoshio	oka et al.	345	74	
	5,543,684	08/96	Kuma	ar et al.	313	495	
	5,551,903	9/96	Kuma	ar et al.	445	24	
	4,900,483	2/90	Witzk	e et al.	264	29.2	
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	5,770,918	6/98	Kawa	te et al.	313	495	·
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	2002/0146958 A1	10/02	Ono	et al.	445	24	
	2003/0048056 A1	3/03	Kitamı	ıra et al.	313	311	
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	11-194134	07/99		Japan	G01N	37/00	Abst., Europea) Equivalent 0 913 508 A3
	11-139815	05/99		Japan	C01B	31/02	Abst.
	0 535 953 B1	01/96		EPO	H01J	1/30	English
	1 122 344 A2	08/01		EPO	D01F	9/127	English
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	2000-223005	8/00		Japan	H01J	1/304	Abst. & Counterpart U.S. Patent 6,283,812
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	WO 99/58748	11/99		PCT	D01F	9/127	English
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	0 913 508 A3	5/99	······	EPO	D01F	9/127	English
	1 096 533 A1	5/01		EPO	H01J	9/02	English
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	1 120 877 A1	8/01		EPO	H02G	5/06	English
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	03-260119	11/91	Japan	D01F	9/127	Abst. & Counterpart U.S. Patent 4,900,483	
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<sup>\*</sup>EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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	6,087,765	07/11/00	Coll et al.	313	309	
	5,872,422	02/16/99	Xu et al.	313	311	
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	4,956,578	9/11/90		Shimizu et al.	315	3	
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<sup>\*</sup>EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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 	5,382,867	01/17/95	Maruo et al.	313	309		
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ø/	6,313,572	11/06/01	Yamada	313	310		
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<sup>\*</sup>EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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<sup>\*</sup>EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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2	Rodriguez et al 3862-3866 (199	•	Engin	eering of Carbon Nanostructures,	" Langmu	ıir 11,	
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<sup>\*</sup>EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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<sup>\*</sup>EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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<sup>\*</sup>EXAMINER: Initial il relerence considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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<sup>\*</sup>EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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<sup>\*</sup>EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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<sup>\*</sup>EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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<sup>\*</sup>EXAMINER: Initial II reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered.

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0,	6,087,765	07/11/00	Coll et al.	313	309			
a,	5,872,422	02/16/99	Xu et al.	313	311			
2	2002/0009637	01/24/02	Murakami et al.	429	213			
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			OREIGN PATENT DOCUMENTS	T	<del>                                     </del>			
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT		
R/	WO 01/93292	12/06/01	PCT					
г		OTHER DOCUMENT(	S) (Including Author, Title, Date, Pertinent Pages, Etc.)					
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EXAMINER PAVID Vn DATE CONSIDERED 12/15/03								

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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